# PLL frequency synthesizer for tuners **BU2622S**

The BU2622S is a PLL frequency synthesizer IC designed for use in high-fidelity audio systems, car stereos, and CD radio cassettes. Featuring low power consumption, low superfluous radiation, a frequency measurement counter, and timer output, this chip is ideal for high-performance systems.

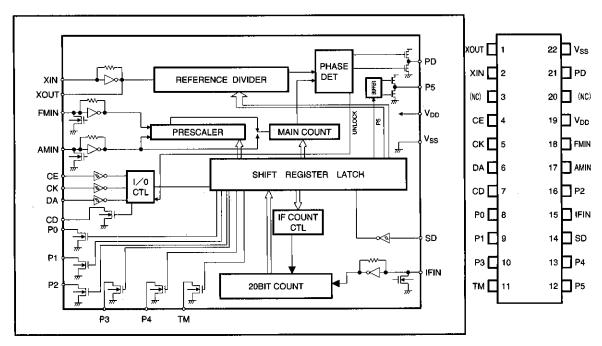
#### Applications

Mini components, car stereos, radio cassettes, receivers, and other frequency generating devices

#### ●Features

- Built-in high-speed prescaler can divide 130MHz
   VCO
- 2) Low power-consumption (during operation : 6.0mA PLL OFF 300  $\mu$ A Typ.)
- 3) Seven standard frequencies: 50kHz, 25kHz, 12.5kHz, 10kHz, 9kHz, 5kHz, and 1kHz.
- 4) Counter for intermediate frequency detection.
- 5) Unlock detection circuit.
- 6) Six output ports.
- 7) SD input.
- 8) Timer output.
- 9) Serial data input (CE.CK.DA)

#### Block diagram



# ●Absolute maximum ratings (Ta = 25°C)

Parameter	Symbol	Limits	Unit	Conditions
Supply voltage	V <sub>DD</sub>	-0.3~7.0	V	V <sub>DD</sub>
Maximum input voltage 1	Vini	-0.3~7.0	٧	CE, CK, DA, SD
Maximum input voltage 2	V <sub>IN2</sub>	-0.3~V <sub>DD</sub> +0.3	V	XIN, FMIN, AMIN, IFIN
Maximum output voltage 1	V <sub>OUT1</sub>	-0.3~10.0	V	Po, P1, P2, P3, P4, TM, CD
Maximum output voltage 2	V <sub>OUT2</sub>	-0.3~V <sub>00</sub> +0.3	V	PD, P <sub>5</sub> , XOUT
Maximum output current	Гоит	0~4.0	mA	Po, P1, P2, P3, P4, TM, CD
Power dissipation	Pd	450*	mW	
Operating temperature	Topr	-25~75	Ç	
Storage temperature	Tstg	<b>−55∼125</b>	ొ	

<sup>\*</sup> When used with Ta at greater than 25 degrees Celsius, derate the power by 4.5 mW for every degree above 25 degrees.

# ● Recommended operating conditions (Ta = 25°C)

Parameter	Symbol	Min.	Тур.	Мах.	Unit
Supply voltage	V <sub>DD</sub> 1	4.0	_	6.0	V

### Explanation of terminals

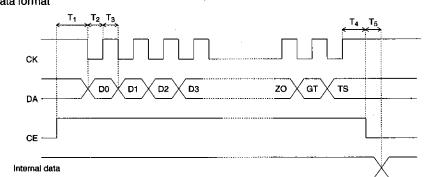
Pin No.	Symbol	Terminal name	Function	1/0
1	XOUT	Crystal oscillation	For generation of standard frequency and internal clock.	OUT
2	XIN	terminal	Connected to 7.2 MHz crystal oscillator.	IN
3	NC	Unused terminal	Not related to the circuits.	:
4	CE	Chip enable	When CE is H, DA is synchronous with the rise of CK and	
5	CK	Clock signal	read to the internal shift register. DA is then latched at the	IN
6	DA	Serial data	timing of the fall of CE. Also, output data is output from the CD terminal synchronous to the rise of CK.	
7	CD	Count data	Frequency data and unlock data are output.	
8	P0			]
9	P1	Output port	Controlled on the basis of input data.	Nch open drain
10	- P3	_		
11	TM	Timer output		
12	P5	Outside	Controlled on the book of legat date	CMOS/3-state
13	P4	Output port	Controlled on the basis of input data.	Nch open drain
14	SD	Input port		IN
15	IFIN	IF input	Intermediate frequency input	IN
16	P2	Output port	Controlled on the basis of input data.	Nch open drai
17	AMIN	AM input	Local input for AM	IN
18	FMIN	FM input	Local input for FM	IN
19	V <sub>DD</sub>	Power supply	Power supply, with 4.0V to 6.0V applied voltage.	
20	NC	Unused terminal	Not related to circuits.	
21	PD	Phase comparison output	High level when value obtained by dividing local output is	3-state
22	Vss	GROUND	higher than standard frequency. Low level when value is lower. High impedance when value is same.	

ullet Electrical characteristics (unless other specified, Ta = 25  $^{\circ}$ C, V<sub>DD</sub> = 5.0V)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions	s
Supply current 1	I <sub>DD1</sub>	=	6.0	10.0	mA	FM <sub>IN</sub> =130MHz, 100mVi	rms
Supply current 2	lpD2	_	0.3	1.0	mA	No input,, PLL=OFF	
Quiescent circuit current	V <sub>IH</sub>	4.0	_	_	V	CE, CK, DA, SD	
"H" level input voltage	Vı∟	<del></del>	_	1.0	V	CE, CK, DA, SD	
"L" level input voltage	11111		_	1.0	μΑ	CE, CK, DA, SD	V <sub>IN</sub> =V <sub>DD</sub>
"H" level input current 1	I <sub>iH2</sub>	_	0.3		μΑ	XIN	V <sub>IN</sub> =V <sub>DD</sub>
"H" level input current 2	1 <sub>IH3</sub>	_	6.0	_	μΑ	FMIN, AMIN, IFIN	V <sub>IN</sub> =V <sub>DD</sub>
"H" level input current 3	l <sub>IL1</sub>	-1.0	_		μΑ	CE, CK, DA, SD	V <sub>IN</sub> =V <sub>SS</sub>
"L" level input current 1	l <sub>IL2</sub>	_	-0.3	_	μA	XIN	V <sub>IN</sub> =V <sub>SS</sub>
"L" level input current 2	lııs	_	-6.0	_	μA	FMIN, AMIN, IFIN	V <sub>IN</sub> =V <sub>SS</sub>
"L" level input current 3	V <sub>OL1</sub>		0.2	0.5	V	Po, P1, P2, P3, P4, TM, CD	l <sub>0</sub> =1.0mA
"L" level output voltage 1	l <sub>OFF1</sub>	_	_	1.0	μΑ	Po, P1, P2, P3, P4, TM, CD	V <sub>0</sub> =10V
"OFF" level leak current 1	V <sub>OL2</sub>	_	_	0.3	V	FMIN, AMIN, IFIN	lo∪т≕0.1mA
"L" level output voltage 2	VoH	V <sub>DD</sub> 1.0	V <sub>DD</sub> — 0.25	_	V	PD, P <sub>5</sub>	l <sub>OUT</sub> =-1.0mA
"H" level output voltage	V <sub>OL4</sub>	_	0.15	1.0	V	PD, P <sub>5</sub>	lout=1.0mA
"L" level output voltage	loff2		_	100	nA	PD	V <sub>OUT</sub> =V <sub>DD</sub>
"OFF" level leak current 2	l <sub>OFF3</sub>	-100		_	nA	PD	V <sub>OUT</sub> =V <sub>SS</sub>
"OFF" level leak current 3	R <sub>F1</sub>		10		МΩ	XIN	
Internal feedback resistor 1	R <sub>F2</sub>		500	<u> </u>	kΩ	FMIN, AMIN, IFIN	
Internal feedback resistor 2	FiNt	_	7.2	_	MHz	XIN, sine wave, C coupling	
Input frequency 1	F <sub>IN2</sub>	10	_	130	MHz	FMIN,sine wave,C coupling	V <sub>IN</sub> ≕50mVrms
Input frequency 2	F <sub>IN3</sub>	0.5	_	30	MHz	AMIN,sine wave,C coupling	V <sub>IN</sub> =70mVrms
Input frequency 3	F <sub>IN4</sub>	0.5	_	15	MHz	AMIF,sine wave,C coupling	V <sub>IN</sub> =50mVrms
Input frequency 4	F <sub>IN5</sub>	0.4		16	MHz	IFIN,sine wave,C coupling	V <sub>IN</sub> =70mVrms
Maximum input amplitude	FINMAX	-	_	1.5	Vrms	XIN,FMIN,AMIN,IFIN,sine wa	ve,C coupling
Minimum pulse width	TW		1.0	_	μs	CK, DA	<del></del>
Input rise time	TR	_	_	500	ns	CE, CK, DA	
Input fall time	TF			500	ns	CE, CK, DA	

O Not designed for radiation resistance.



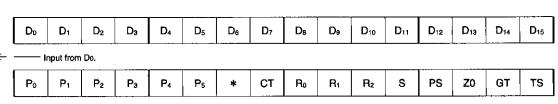


 $T_1 \ge 1.5 \,\mu\,\text{SEC}$ 

 $T_2,T_3>0~\mu~SEC$ 

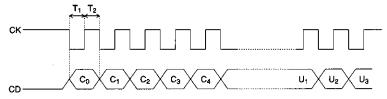
T<sub>4</sub>>0 μ SEC

 $T_5 > 1.5 \,\mu\,\text{SEC}$ 

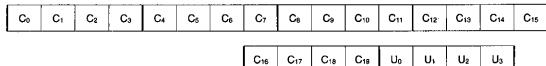


\* : (0) is input.

## Output data format CE output is set to LO.



Figures for output assume the presence of pullup resistance.  $T_1,T_2>1~\mu\,{\rm SEC}$  Output data format



← Input done from Co.

Explanation of the data

( 1 ) Division data : For  $D_0$  through  $D_{15}$  (When  $S\,=\,1,$  use  $D_4$  through  $D_{15.})$ 

D₀	D <sub>1</sub>	D <sub>2</sub>	D₃	D₄	Ð₅	D <sub>6</sub>	D <sub>7</sub>	D₃	D <sub>9</sub>	D <sub>10</sub>	D <sub>11</sub>	D <sub>12</sub>	D <sub>13</sub>	D <sub>14</sub>	D <sub>15</sub>	
Exam	oles:															
Divide	d frequ	ency =	1106 (D	)) ÷2=	553 (D)	==229	(H) S=	0								
1	0	0	1	0	1	0	0	0	1	0	0	0	0	0	0	
Divide	d frequ	ency =	1107 (D	) =453	3 (H)	s=	1, PS	=1								
1	1	0	0	1	0	1	0	0	0	1	0	0	0	0	0	
Divide	d frequ	ency = 1	926 (D)	=39E	(H)	S=1	, PS=	0								
×	×	×	×	0	1	1	1	1	0	0	1	1	1	0	0	

- (2) CT: Frequency measurement beginning data
  - 1: Begins measurement.
  - 0 : Resets internal counter, IFIN goes to pull-down.
- (3) Output port control data: Po, P1, P2, P3, P4, P5
  - 1: Open drain output ON
- (P5 is LO)
- 2: Open drain output OFF (P5 is HI)
- (4) Z0: Ps is set to high impedance.
- (5) Ro, R1, R2, standard frequency data

	Data		Standard frequency
R₀	R <sub>1</sub>	R <sub>2</sub>	
0	0	0	25kHz
0	0	1	12.5kHz
0	1	0	50kHz
0	1	1	10kHz
1	0	0	5kHz
1	0	1	9kHz
_ 1	1	0	1kHz
1	1	1	* PLL OFF

- \* FMIN = pulldown, AMIN = pulldown, PD = high impedance
- (6) S: switch between FMIN and AMIN
  - 0:FMIN
  - 1: AMIN
- (7) PS: If this bit is set to ON while AMIN is selected, swallow counter division is possible.

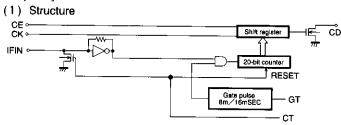
# (8) GT: Frequency measurement time and unlock detection ON/OFF

СТ	GT.	GT Frequency measurement Unlock		Dața output
0	0	OFF	OFF	NG
0	1	OFF	ON	·
1	0	ON Gate time = 8 mSEC	ON	OK
1	1	ON Gate time = 16 mSEC	ON	

(9) TS: Test data

(0) is input

#### Frequency counter

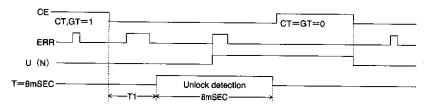


(2) How the frequency counter operates When control data CT equals 1, the 20-bit counter and the amp go into operation. When CT equals 0, amp input goes to pulldown and the counter is reset. Measuring time (gate pulse) is selected (8mSEC/16mSEC) on the basis of control data GT. When control data CT equals 0, the counter is reset.

# (3) Explanation of output data Co: LSB C10: MSB

Unlock detection

When control data GT equals 1, or CT equals 1, the unlock detection circuit goes into operation for 8mSEC. When CT equals 1, the unlock detection circuits stops operating before the frequency counter gate pulse is emitted. When CT equals 0, or GT equals 0, the unlock detection circuit is reset.



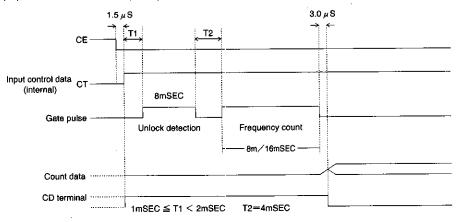
1mSEC≨T1<2mSEC

# Explanation of the output data

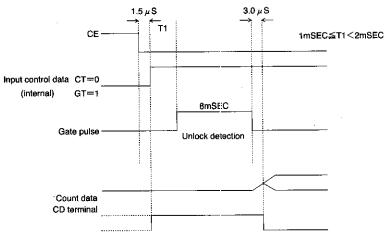
U0 U1 U2 U3 0 0 0 **ERR** < 1.1  $\mu$  SEC 0 0  $1.1 \,\mu\,\mathrm{SEC}$  < ERR 2.2 µ SEC 2.2 μ SEC < **ERR** < 3.3 μ SEC  $3.3 \,\mu\,\mathrm{SEC}$  < ERR < 4.4 μ SEC 1 1  $4.4 \mu$ SEC < **ERR** 

Frequency counter and unlock detection

(1) When CT = 1: Frequency count and unlock detection are carried out.

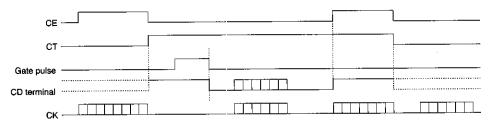


(2) When CT = 0 and GT = 1: Only unlock detection is carried out.

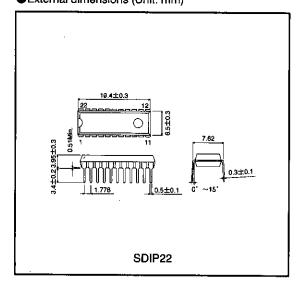


Explanation of CD terminal

While frequency measurement or unlock detection is in progress, the CD terminal goes to HI. When either of these operations finishes, it goes to LO. When the control data is such that CT == 0 and GT = 0, the SD terminal input is displayed in reverse video.



●External dimensions (Unit: mm)



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